

Notice of References Cited	Application/Control No. 10/728,562	Applicant(s)/Patent Under Reexamination ALFANO ET AL.	
	Examiner Jerome Jackson Jr.	Art Unit 2815	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-2002/0175324	11-2002	Razeghi, Manijeh	257/14
	C	US-2003/0176003	09-2003	Schaff et al.	438/47
	D	US-2002/0096675	07-2002	Cho et al.	257/25
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	L	US-			
	M	US-			

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NON-PATENT DOCUMENTS

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	U	Raisky et al, Applied Physics Letters, Vol.79 No. 3, 16 July 2001, "Carrier screening...structures" pp.430-432
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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